Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/715,376	SUN ET AL.		
Examiner	Art Unit		
Thinh T. Nguyen	2818		

SEARCHED						
Class	Subclass	Date	Examiner			
257	295	7/30/2005	TTN			
257	30	7/30/2005	TTN			
257	421	7/31/2005	TTN			
257	427	7/31/2005	TTN			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
EAST		7/31/2005	TTN		
EAST		7/30/2005	TTN		